

**Search Notes**

Application/Control No.

10/672,437

Examiner

Hiep Nguyen

Applicant(s)/Patent under  
Reexamination

NALBANT, MEHMET K.

Art Unit

2816

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PG-PUB Search		11-03-06	JH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST See attachment	11.03.06	JH